

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10768795	KANEVSKY ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	SYLING YEN	2166

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
714	5 (limited text search), 25	10/20/2008	sy
707	204	10/20/2008	sy
382	181	10/20/2008	sy
380	283	10/20/2008	sy

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
inventor name search	9/21/2007	sy
EAST limited text search	4/2/2008	sy
EAST limited text search with patterns, extraction, consecutive, and repeat	10/20/2008	sy
Consulted allowable subject matters with SPE Hosain alam and Primary Khanh Pham	10/16/2008	sy
ACM: pattern wildcard consecutive	10/20/2008	sy
IEEE: pattern wildcard consecutive	10/20/2008	sy
Google: pattern wildcard consecutive	10/20/2008	sy

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
714	5, 25	10/20/2008	sy
707	204	10/20/2008	sy
382	181	10/20/2008	sy
380	283	10/20/2008	sy

/S. Y./  
Examiner Art Unit 2166